

**Search Notes**

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Examiner

VAN T. PHAM

Applicant(s)/Patent under  
Reexamination

YEN, HUNG-TIEN

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
369	47.35, 52.1, 53.15.	11/30/2005 <i>updated on 6/3/06</i>	VP <i>VP</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB	text search	6/3/2006	VP
Interference search (see search history printout).			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB)  369 (text search only see search history printout).	6/3/2006	VP